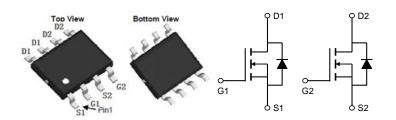


General Description

The KSP9926 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible onresistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

SOP-8 Pin Configuration



Product Summary

V _{DS} (V)	V_{DS} (V) $R_{DS(on)}$ (m Ω)	
20	26 at VGS = 10 V	6
20	35 at V _G S = 4.5 V	4.5

Features

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current

Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	20	V
V _G s	Gate-Source Voltage	±12	V
	Drain Current – Continuous (T _C =25°C)	6	А
lo	Drain Current – Continuous (Tc=100°C)	3.8	А
I _{DM}	Drain Current – Pulsed¹	24	А
D-	Power Dissipation (Tc=25°C)	1.25	W
P _D	Power Dissipation (Tc=100℃)	0.05	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	℃
TJ	Operating Junction Temperature Range	-55 to 150	℃

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		53	°C/W
Rejc	Thermal Resistance Junction to Case		2.8	°C/W



Electrical Characteristics (T_J =25 °C, unless otherwise noted) Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =250 u A	20			V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =20V , V _{GS} =0V , T _J =25℃			1	uA
		V _{DS} =20V , V _{GS} =0V , T _J =125℃			15	uA
Igss	Gate-Source Leakage Current	V _{GS} =±10V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V , I_{D} =5A		26	32	mΩ
		V _{GS} =4.5V , I _D =4A		35	45	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D =250uA	0.5	0.8	1.5	V
gfs	Forward Transconductance	V _{DS} =5V , I _S =5A		20		S

Dynamic and switching Characteristics

Qg	Total Gate Charge		 11	
Qgs	Gate-Source Charge	V_{DS} =10V , V_{GS} =5V , I_{D} =3A	 1.8	 nC
Q_{gd}	Gate-Drain Charge		 2.1	
$T_{d(on)}$	Turn-On Delay Time		 9	
Tr	Rise Time	V _{DS} =10V,I _D =1A	 10	 ns
$T_{d(off)}$	Turn-Off Delay Time	Vgs=5V,Rg=6Ω	 18	 115
T _f	Fall Time		 5	
Ciss	Input Capacitance		 660	
Coss	Output Capacitance	V _{DS} =10V , V _{GS} =0V , F=1MHz	 155	 pF
C _{rss}	Reverse Transfer Capacitance		 92	

Drain-Source Diode Characteristics and Maximum Ratings

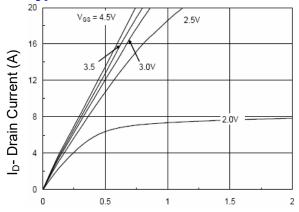
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			6	Α
lsм	Pulsed Source Current				15	Α
$V_{ extsf{SD}}$	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V

Note:

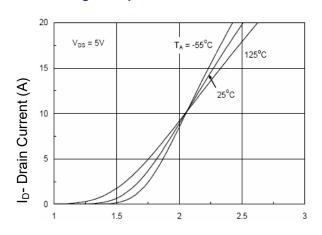
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- **3.** Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)
Fig.1 Output Characteristics



Vgs Gate-Source Voltage (V)
Fig. 2 Transfer Characteristics

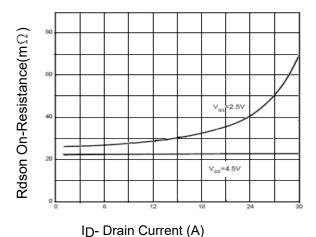


Fig. 3 Rdson- Drain Current

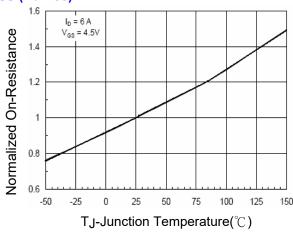
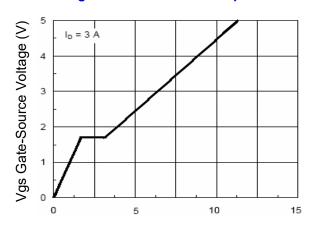


Fig. 4 Rdson-JunctionTemperature



Qg Gate Charge (nC) Fig. 5 Gate Charge

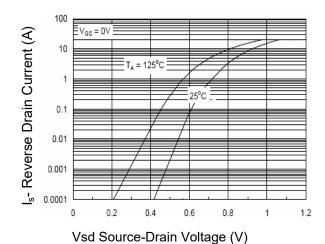
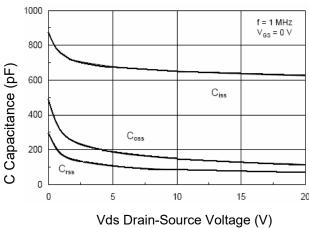


Fig. 6 Source- Drain Diode Forward





Figu.7 Capacitance vs Vds

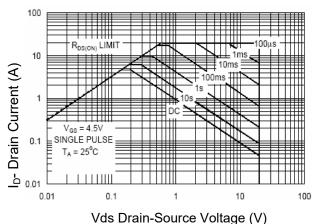


Fig.9 Safe Operation Area

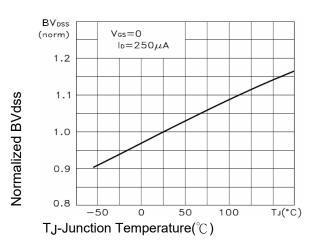


Fig. 8 BVDSS vs Junction Temperature

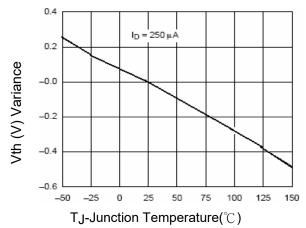


Fig. 10 V_{GS(th)} vs Junction Temperature

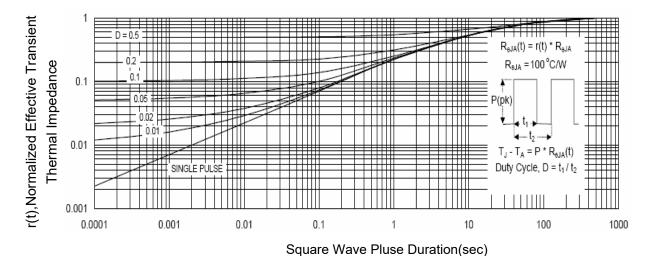


Fig.11 Normalized Maximum Transient Thermal Impedance



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